

FMOS3400A-Q1

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FMOS3400A-Q1

30V N-Channel Enhancement Mode MOSFET

Features

- High dense cell design for extremely low $R_{DS(ON)}$.
- Exceptional on-resistance and maximum DC current capability.
- Lead -free parts meet RoHS requirements.
- Qualified to AEC-Q101 standards for high reliability.
- Suffix "-H" dinicates Halogen-free part, ex.FMOS3400A-Q1-H.

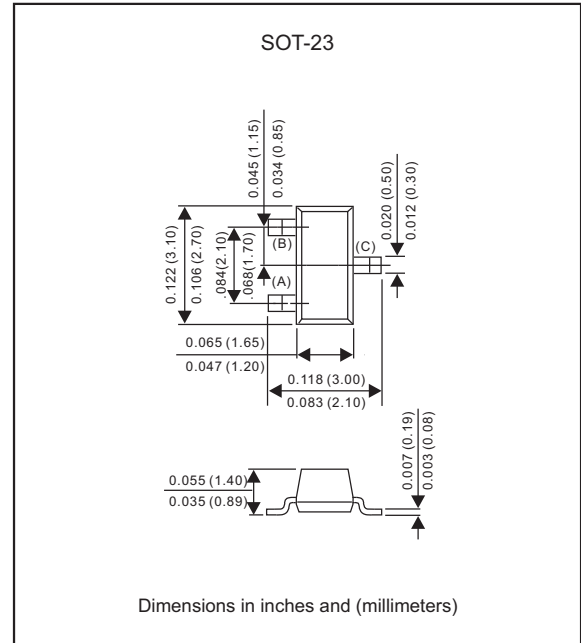
Application

- Load/Power switching.
- Interfacing switching.

Mechanical data

- Epoxy : UL94-V0 rated flame retardant.
- Case : Molded plastic, SOT-23.
- Terminals : Solder plated, solderable per MIL-STD-750, Method 2026.
- Mounting position : Any.
- Weight : Approximated 0.008 gram

Package outline



Maximum ratings (AT $T_A = 25^\circ\text{C}$ unless otherwise noted)

PARAMETER	Symbol	MIN.	TYP.	MAX.	UNIT
Drain-source voltage	V_{DS}			30	V
Continuous drain current	I_D			5.8	A
Drain current-pulsed (note 1)	I_{DM}			30	A
Gate - source voltage	V_{GS}			± 12	V
Power dissipation	P_D			400	mW
Thermal resistance junction to ambient (note 2)	$R_{\theta JA}$		313		$^\circ\text{C/W}$
Operation junction temperature range	T_J	-55		+150	$^\circ\text{C}$
Storage temperature range	T_{STG}	-55		+150	$^\circ\text{C}$

Note :

1. Repetitive Rating : Pulse width limited by maximum junction temperature.
2. Surface Mounted on FR4 Board, $t < 5$ sec.

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Electrical characteristics (At $T_A = 25^\circ\text{C}$ unless otherwise noted)

PARAMETER	CONDITIONS	Symbol	MIN.	TYP.	MAX.	UNIT
Off characteristics						
Drain - source breakdown voltage	$V_{GS} = 0V, I_D = 250\mu A$	$V_{(BR)DSS}$	30			V
Zero gate voltage drain current	$V_{DS} = 24V, V_{GS} = 0V$	I_{DSS}			1.0	μA
Gate - source leakage current	$V_{GS} = \pm 12V, V_{DS} = 0V$	I_{GSS}			± 100	nA

On characteristics (note 1)

Gate threshold voltage	$V_{DS} = V_{GS}, I_D = 250\mu A$	$V_{GS(th)}$	0.6		1.5	V
Drain - source on-resistance	$V_{GS} = 10V, I_D = 5.8A$ $V_{GS} = 4.5V, I_D = 5.0A$	$R_{DS(ON)}$			35 40	m Ω
Forward transconductance	$V_{DS} = 5.0V, I_D = 5A$	g_{FS}	8.0			S

Dynamic characteristics (note 2)

Input capacitance	$V_{DS} = 15V, V_{GS} = 0V, f = 1MHz$	C_{iss}			1155	pF
Output capacitance		C_{oss}		108		
Reverse transfer capacitance		C_{rss}		84		
Gate resistance	$V_{DS} = 0V, V_{GS} = 0V, f = 1MHz$	R_G			3.6	Ω

Switching characteristics (note 2)

Turn-on delay time	$V_{GS} = 10V, V_{DS} = 15V,$ $R_L = 2.7\Omega, R_{GEN} = 3.0\Omega$	$t_d(on)$			5.0	ns
Turn-on rise time		t_r			7.0	
Turn-off delay time		$t_d(off)$			40	
Turn-off fall time		t_f			6.0	

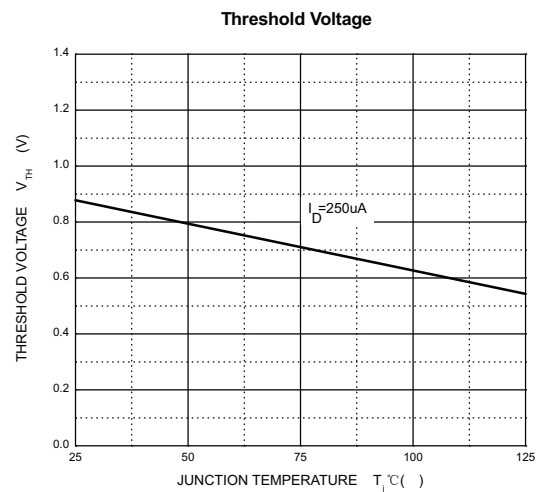
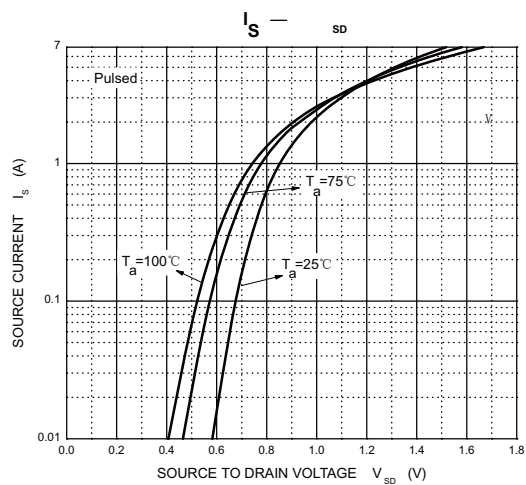
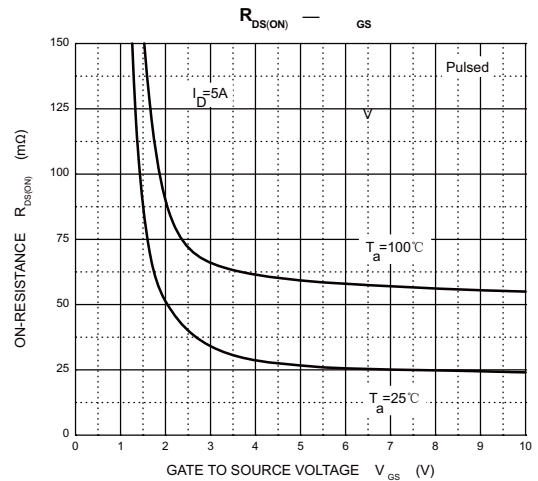
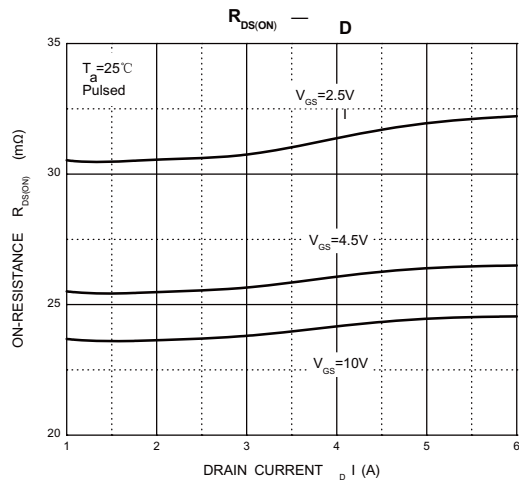
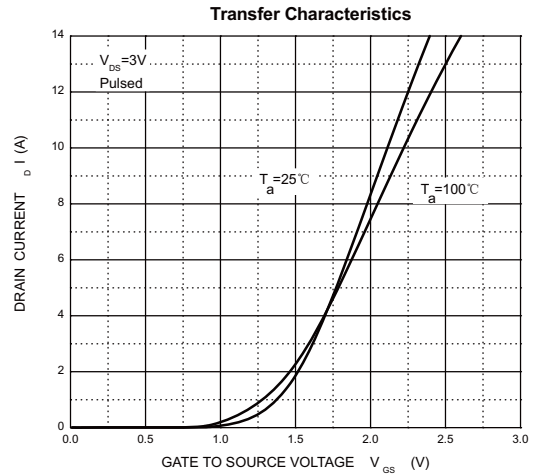
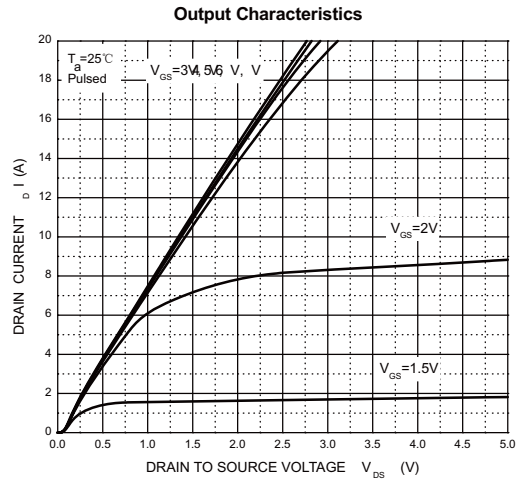
Drain source diode characteristics and maximum ratings

Diode forward voltage (note 1)	$I_S = 1.0A, V_{GS} = 0V$	V_{SD}			1.0	V
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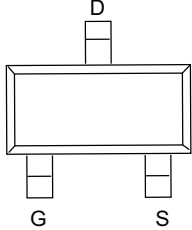
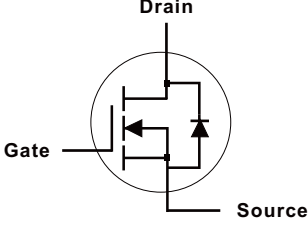
Notes:

1. Pulse test: pulse width $\leq 300\mu s$, duty cycle $\leq 2\%$.
2. Guaranteed by design, not subject to production testing.

Rating and characteristic curves (FMOS3400A-Q1)

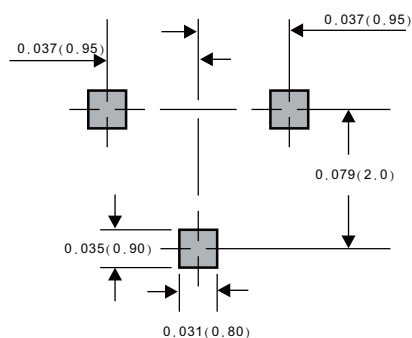


FMOS3400A-Q1**Pinning information**

Pin	Simplified outline	Symbol
Pin D Drain Pin G Gate Pin S Source		

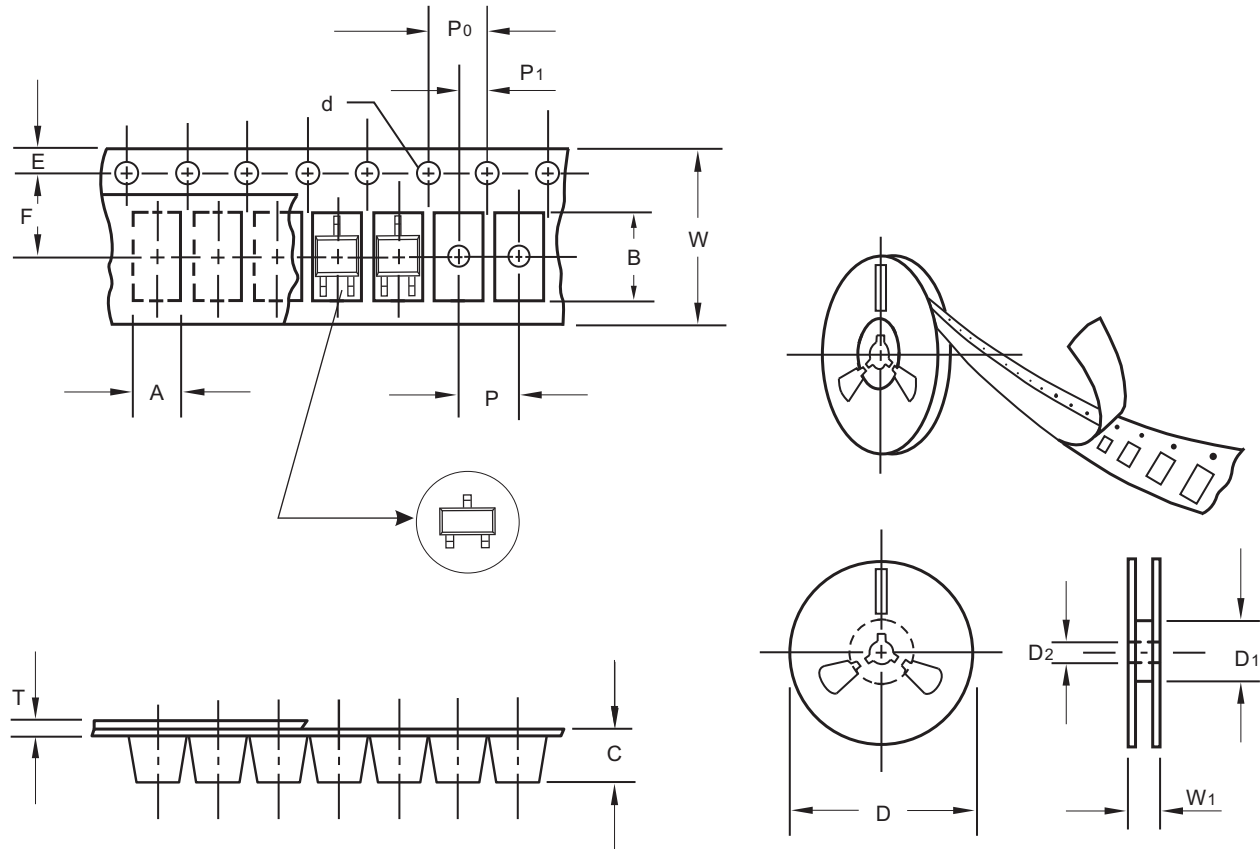
Marking

Type number	Marking code
FMOS3400A-Q1	3400

Suggested solder pad layout**SOT-23****Dimensions in inches and(millimeters)**

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Packing information



unit:mm

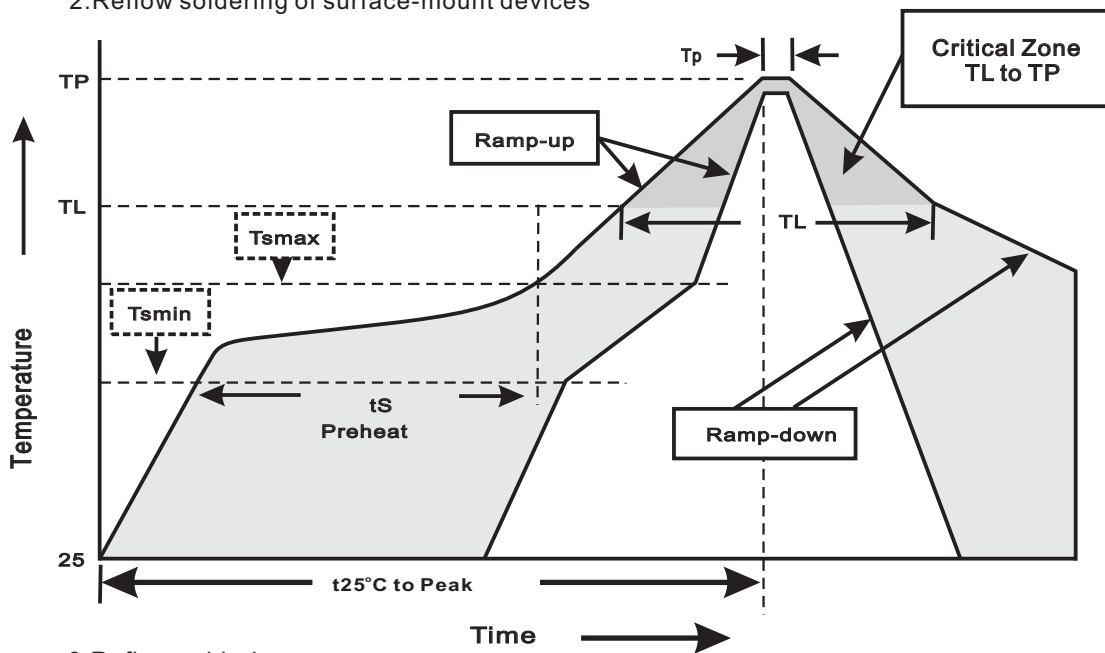
Item	Symbol	Tolerance	SOT-23
Carrier width	A	0.1	3.15
Carrier length	B	0.1	2.77
Carrier depth	C	0.1	1.22
Sprocket hole	d	0.1	1.50
13" Reel outside diameter	D	2.0	-
13" Reel inner diameter	D1	min	-
7" Reel outside diameter	D	2.0	178.00
7" Reel inner diameter	D1	min	55.00
Feed hole diameter	D2	0.5	13.00
Sprocket hole position	E	0.1	1.75
Punch hole position	F	0.1	3.50
Punch hole pitch	P	0.1	4.00
Sprocket hole pitch	P0	0.1	4.00
Embossment center	P1	0.1	2.00
Overall tape thickness	T	0.1	0.23
Tape width	W	0.3	8.00
Reel width	W1	1.0	12.0

Note: Devices are packed in accordance with EIA standard RS-481-A and specifications listed above.

Reel packing

PACKAGE	REEL SIZE	REEL (pcs)	COMPONENT SPACING (mm)	BOX (pcs)	INNER BOX (mm)	REEL DIA, (mm)	CARTON SIZE (mm)	CARTON (pcs)	APPROX. GROSS WEIGHT (kg)
SOT-23	7"	3,000	4.0	30,000	183*123*183	178	382*257*387	240,000	11.6

1.Storage environment: Temperature=5°C~40°C Humidity=55%±25%
2.Reflow soldering of surface-mount devices



Profile Feature	Soldering Condition
Average ramp-up rate(T_L to T_P)	$<3^{\circ}\text{C}/\text{sec}$
Preheat -Temperature Min(T_{min}) -Temperature Max(T_{max}) -Time(min to max)(t_s)	150°C 200°C $60\sim 120\text{sec}$
T_{max} to T_L -Ramp-upRate	$<3^{\circ}\text{C}/\text{sec}$
Time maintained above: -Temperature(T_L) -Time(t_L)	217°C $60\sim 260\text{sec}$
Peak Temperature(T_P)	$255^{\circ}\text{C}-0/+5^{\circ}\text{C}$
Time within 5°C of actual Peak Temperature(t_P)	$10\sim 30\text{sec}$
Ramp-down Rate	$<6^{\circ}\text{C}/\text{sec}$
Time 25°C to Peak Temperature	$<6\text{minutes}$